The Physics of Moire Metrology

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Contents

		2.2.6. Partial derivatives	30			
		2.2.7. Self-healing	34			
		2.2.8. Grating and fringe pattern phase	3:			
		2.2.9. Spatial correlation of two moire patterns	30			
		2.2.10. Radial and circular gratings	30			
Refere		[12] [기념시기 (12) 기업시기 (12)	3			
χî	Symbo		3			
Cha	pter 3.	Limitations on Accuracy Due to the Use				
Chapter 5.		of Light				
1	3.1	Introduction	39			
	3.2	Properties of Light	40			
	3.3	Light Coherence and Radiation Modes	4:			
3.4		Limitations on Spatial Resolution—The				
		Uncertainty Principle				
	3.5	Mode Statistics as a Means to Improve the	Y.			
		Optical Resolution				
	3.6	Summary	5			
	Refere	rences				
	Symbo	ols	5			
Cha		Halamakia as Mala Contamina of These				
Chapter 4.		Holographic vs. Moire Contouring of Three- Dimensional Diffusive Objects				
			- 3			
	4.1	Introduction to the Metrology of Diffusive	-			
	4.0	Objects	5			
	4.2	Holography and Holographic Interferometry	54			
		4.2.1. Holography: Introduction	54			
		4.2.2. Recording process	5:			
		4.2.3. Reconstruction	50 51			
	. 8.	4.2.4. Holographic interferometry)			
	1 B	4.2.5. Double exposure, contouring, and	5			
	4.3	sandwich holography				
- 1	4.4	Shadow Moire and the Grating Hologram	6			
	4.4	Deferred Analysis in Shadow Moire	6			
	4.5	Slope Direction Determination in Shadow Moire 4.5.1. Infinite fringe shadow moire	6			
			6			
		4.5.2. Finite fringe shadow moire	0			

CONTENTS vii

	4.6	Noise Reduction in Moire Contouring by Double Exposure	67
	4.7	Slope Contouring by Shearing Shadow Moire	0,
		Techniques	70
	4.8	Vibration Analysis	72
1.5	4.9	Summary	72
	Refere		73
Symbo			74
	2)		1500
Cha	pter 5.	Moire Analysis of Strain	75
10.5	5.1	Background on Stress and Strain	75
	5.2	Strain Measurements	77
	5.3	Mapping Shear Strain	80
	5.4	Analysis of Strain by Moire Interferometry	81
	5.5	Analysis of Strain by Moire Deflectometry	84
	Refere	ences	86
	Symbo	ols	87
		THE RESERVE OF A PROPERTY OF A PARTY.	
Cha	pter 6.	Moire Deflectometry	89
	6.1	Introduction	89
	6.2	Geometrical Analysis of Moire Deflectometry	90
	6.3	Ray Deflection vs. Phase Retardation	93
	6.4	Sensitivity of Moire Deflectometry	102
21	6.5	Diffraction by a Grating—Talbot Effect	102
	6.6	Diffraction by a Finite Aperture	103
	6.7	The Effect of Beam Quality	104
45	6.8	The Effect of Grating Imperfection	107
	Refere	ences	109
Cha	pter 7.	Applications of Moire Deflectometry	111
	7.1	Introduction	111
	7.2	Experimental Techniques in Moire	
	00.40m	Deflectometry	112
CALL		7.2.1. Configurations of the moire	
Page .		deflectometer	112
		7.2.2. Real time vs. deferred analysis methods	117

viii CONTENTS

		Applications of Moire Deflectometry in Static Systems 12				
		Systems				
		7.3.1. Beam deflecting		24		
		7.3.2. Focal length of		27		
	7.4	7.3.3. General wave		33		
			Deflectometry in Dynamic	•		
		Systems		36		
		7.4.1. Flow systems		36		
		7.4.2. Thermal lensing		49		
7.5		Applications of Moire Deflectometry to MTF Analysis 157				
		Analysis				
		7.5.1. Experimental		57		
		7.5.2. Applications	of MTF analysis in static			
		systems	84. N	59		
18		7.5.3. Applications of	f MTF analysis in dynamic			
507		systems	1	64		
	7.6	Miscellaneous Applications of Moire				
(3)	1	Deflectometry				
		7.6.1. Level based or	n moire deflectometry 1	67		
er.			hanges of high surface area			
		electrodes		69		
8%		7.6.3. Frequency ma		69		
	40	7.6.4. Hybrid Talbo		70		
	Refere		The state of the s	71		
		1104007/1203	lwah sa Abhara - Sa •			
Appendix. Aberra		Aberration Analysis U	sing Moire Deflectometry 1	75		
	A.1	Background	1	75		
	A.2	Experimental Technic	jues 1	76		
		A.2.1. Defocusing		78		
		A.2.2. Spherical abe	rrations 1	78		
	- Ai	A.2.3. Coma		81		
110		A.2.4. Astigmatism		83		
	A.3	Normalization of the		84		
	Refer			84		
	-121			100		
Aut	hor Ind	ex	1	85		
_			energy of the second			
Sul	oject Inc	ex	Capital Nel Sovicia	87		